

(Ho-dong), 113, Yejik-ro, Cheoin-gu, Yongin-si, Gyeonggi-do, Korea Tel: +82-31-339-9970 Fax: +82-31-624-9501 www.e-ctk.com

TEST REPORT

According to : FCC 47CFR part 15 subpart C

Test Report No. : CTK-2015-00213

Date of Issue : February 14, 2015

FCC ID : 2ABS5-EWC-4000

Equipment Under Test : HLCRIO132

Kind of Product : Easy One Touch Wireless Qi Standard Charging Car Mount

Applicant : HSM CO., LTD.

Applicant Address : 2F Yeong-jae Bldg., 40, Nonhyeon-ro 24gil, Gangnam-gu,

Seoul, 135-855, Korea

Manufacturer : HSM CO., LTD.

Manufacturer Address : 2F Yeong-jae Bldg., 40, Nonhyeon-ro 24gil, Gangnam-gu,

Seoul, 135-855, Korea

Contact Person : Gyu Gwang, Choi / Project Manager

Telephone : +82-2-573-5466

Received Date : January 26, 2015

Test period : Start : January 26, 2015 End : February 14, 2015

Test Results : \square In Compliance \square Not in Compliance

The test results presented in this report relate only to the object tested.

Tested by

Y. T. Lee

Young-taek Lee Test Engineer

Date: February 14, 2015

Reviewed by

Young-Joon, Park Technical Manager

Date: February 14, 2015

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REPORT REVISION HISTORY

Date	Revision	Page No
February 14, 2015	Issued (CTK-2015-00213)	All

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1.0 General Product Description

Type of equipment	Easy One Touch Wireless Qi Standard Charging Car Mount
Equipment model name	HLCRIO132
Frequency Range	110 kHz – 205 kHz
Antenna type	Coil antenna
Power Source	CAR ADAPTER Input: DC 12 V - 24 V Output: DC 5 V, 2.0 A Test Voltage and Frequency: DC 5 V, -

Model Differences 1.1

Not applicable

1.2 **Device Modifications**

The following modifications were necessary for compliance:

Not applicable

1.3 **Peripheral Devices**

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
CAR ADAPTER	HAEM Co., Ltd.	ECA-P10XBK	DW1D521DS/B-E	-
Test Jig	OPENTECH Inc.	-	=	=
Wireless Charging Receiver	OPENTECH Inc.	OWS-303R	-	-
Wireless Charging Cover	RFTech Co., Ltd.	EBC-1G6WWE	RT0C802AS/4-E	-
Mobile Phone	Samsung Electronics Co., Ltd.	SCH-1535	-	A3LSCHI535

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1.4 EUT Operating Modes

Equipment under test was operated during the measurement under the following conditions:

□ Charging and communication mode

Modulation Type: CW (Continuous Wave)

Output Power: Max. 10.48 dBuV/m (Frequency 115.4 kHz, Test Distance 3 m)

TX Duty Cycle: 100 % by measurement

1.5 Test Modes

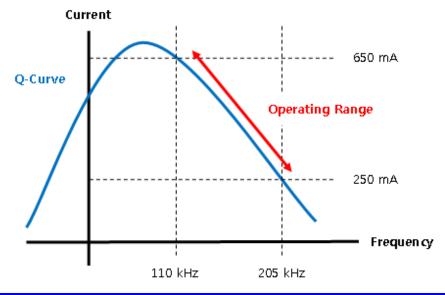
This device has been tested below conditions:

[Test Mode #1]

Frequency	Charging current	Note
110 kHz	650 mA	Low Frequency, Max. Load
157.5 kHz	425 mA	Middle Frequency, Medium Load
205 kHz	250 mA	High Frequency, Min. Load

This device has been tested with the various resistors to simulate the various load conditions of the client device. The charging current was controlled from 250 mA (Min.) to 650 mA (Max.) using the resistors and three types of Jig board with circular coil.

- 1) EUT has a range of the operating frequency from 110 kHz to 205 kHz and It has a range of the output current from 250 mA to 650 mA when output voltage is DC 5 V.
- 2) If the operating frequency is 110 kHz, the maximum output current is 650 mA and If the operating frequency is 205 kHz, the minimum output current is 250 mA.



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- 3) To the simulation of the power transmission in from 110 kHz to 205 kHz. In the full range of the operating frequency, Normal operating condition, the test frequency is three which are the High, Middle and Low frequency of 110 kHz, 157.5 kHz and 205 kHz.
- 4) In order to operate EUT in three operating frequencies, three types of Test Jig were used
- 5) The Wireless Charging Cover was used as Test Jig is actually used with the EUT.
- 6) The EUT to operate at a steady-state output current, the Wireless Charging Cover was not to combined with a smart phone. The DC output of the Wireless Charging Cover was connected to the resistor. As follows, the three types of Test Jig was prepared and tested.
- 7) Test Jig #1 Operating Frequency : 110 kHz, Output Voltage : DC 5 V, Output Current : 0.65 A Calculation of resistor value : $I=\frac{V}{R}$, $0.65\,A=\frac{5\,V}{R}$, $R=\frac{5\,V}{0.65\,A}$, $R\approx7.69\,\Omega$
- 8) Test Jig #2 Operating Frequency : 157.5 kHz, Output Voltage : DC 5 V, Output Current : 0.425 A Calculation of resistor value : $I = \frac{V}{R}$, $0.425 \, A = \frac{5 \, V}{R}$, $R = \frac{5 \, V}{0.425 \, A}$, $R \approx 11.76 \, \Omega$
- 9) Test Jig #3 Operating Frequency : 205 kHz, Output Voltage : DC 5 V, Output Current : 0.25 A Calculation of resistor value : $I = \frac{V}{R}$, $0.25 \text{ A} = \frac{5 \text{ V}}{R}$, $R = \frac{5 \text{ V}}{0.25 \text{ A}}$, $R = 20 \Omega$

[Test Mode #2]

Support Equipment	Battery status	Note
Mobile Phone	< 1%	Max. Load
Mobile Phone	50 %	Medium Load

Note: The Charging is not operation when 100% fully charged status.

This device has been tested with the Mobile phone.

Mobile phone is on Airplane Mode.

Mobile phone's battery status was checked by display battery percentage function.





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1.6 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.7 Test Facility

The measurement facility is located at (Ho-dong), 113, Yejik-ro, Cheoin-gu, Yongin-si, Gyeonggi-do, Korea.

1.8 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Registration Number	Logo
USA	FCC	FCC Part 15 & 18 EMI (Electromagnetic Interference / Emission)	805871	E
JAPAN	VCCI	VCCI V-3 EMI (Electromagnetic Interference / Emission)	C-986 T-1843 R-3627 G-387	VEI
KOREA	MSIP	EMI (Electromagnetic Interference / Emission) EMS (Electromagnetic Susceptibility / Immunity)	KR0025	

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2.0 Summary of tests

FCC Part Section(s)	Parameter	Status (note 1)
15.203	Antenna requirement	N/A
15.204	External radio frequency power amplifier and antenna modifications	N/A
15.207	Conducted emissions	N/A
15.209	Radiated emissions	Complies

Footnotes for N/A's:

- § 15.203 is not applicable because the transmitter is provided with an integral antenna.
- § 15.204 is not applicable because the transmitter is provided with an integral antenna.
- § 15.207 is not applicable because the transmitter is intended to be used in car.

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2.1 Power line conducted emissions (Section 15.207)

Test Location

Not Applicable (Use only the DC voltage of the vehicle.)

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Procedures

The EUT was placed on a non-metallic table 0.8m above the metallic, grounded floor and 0.4m from the reference ground plane wall. The distance to other metallic surfaces was at least 0.8m.

Amplitude measurements were performed with a quasi-peak detector and an average detector.

Limit

-15.207(a)

Test Data

Frequency	Conducted Limit (dBuV)				Conducted Limit (dBuV)		
(MHz)	Quasi-peak	Average					
0.15 ~ 0.5	66 to 56*	56 to 46*					
0.5 ~ 5	56	46					
5 ~ 30	60	50					

^{*} Decreases with the logarithm of the frequency.

EUT Operating Modes

The EUT is an intentional radiator is operated at 110 kHz to 205 kHz. We have tested three frequencies, Low (110 kHz), Middle (157.5 kHz), High (205 kHz), for power line conducted emissions test.

* Middle (157.5 kHz): Exactly half way between 110 kHz and 205 kHz.

Test Results The requirements are:	
Complies	

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^{*} Measurement procedures was In accordance with ANSI C63.4-2009 7.3.3, 7.3.4



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2.2 Radiated emissions (Section 15.209)

Test Location

\boxtimes	10 m SAC (test distance :] 10	m,	\boxtimes	3	m)
	3 m SAC (test distance: 3	m	1)				

- 1) In the frequency range of 9 kHz to 30 MHz, magnetic field is measured with Loop Antenna. The Test Antenna is positioned with its plane vertical at 1m distance from the EUT. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.
- 2) In the frequency rage above 30 MHz, Bi-Log Test Antenna(30 MHz to 1 GHz) and Horn Test Antenna(above 1 GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is carried from 1m to 4m above the ground to determine the maximum value of the field strength. The emissions levels at both horizontal and vertical polarizations should be tested.

The spectrum analyzer is set to:

Frequency Range = 9 kHz \sim 1 GHz RBW = 100 kHz for f < 1 GHz, 9 kHz for f < 30 MHz VBW \geq RBW Sweep = Auto

Limit

- 15.209(a)

Frequency [MHz]	Field Strength [uV/m]	Measurement Distance [Meters]
0.009-0.490	2400/F(kHz)	300
0.490-1.705	24000/F(kHz)	30
1.705-30	30	30
30-88	100**	3
88-216	150**	3
216-960	200**	3
Above 960	500	3

^{**} Except as provided in 15.209(g).fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54-72MHz, 76-88MHz, 174-216MHz, 470-806MHz. However, operation within these frequency bands is permitted under other sections of this Part, e.g.15.231 and 15.241.

Note:

1) For above 1 GHz, the emission limit in this paragraph is based on measurement instrumentation employing an average detector, measurement using instrumentation with a peak detector function, corresponding to 20 dB above the maximum permitted average limit.

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Test Setup:

1) For field strength of emissions from 9 kHz to 30 MHz

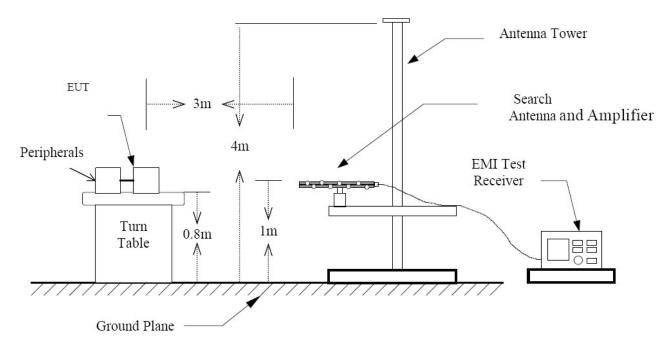
Loop Antenna

EMI test receiver

Turn 0.8m

Table 0.8m

2) For field strength of emissions from 30 MHz to 1 GHz



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Test Results

EUT	Easy One Touch Wireless Qi Standard Charging Car Mount	Model	HLCRIO132
Frequency Range	9 kHz ~ 1 GHz	Test mode	TX

The requirements are:

Test Data

Fundamental Test Data: FET #1 (CSD17308Q3, Texas Instruments)

[Test Mode #1]

Operating Frequency: 110 kHz

	Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
	113.40	61.38	20.18	5.9	-80	7.46	46.51	39.05	Peak
ı	113.40	61.01	20.18	5.9	-80	7.09	26.51	19.42	Average

Operating Frequency: 157.5 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
157.00	55.68	20.18	5.9	-80	1.76	43.69	41.93	Peak
157.00	55.23	20.18	5.9	-80	1.31	23.69	22.38	Average

Operating Frequency: 205 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
204.00	50.66	20.18	5.9	-80	-3.26	41.41	44.67	Peak
204.00	50.24	20.18	5.9	-80	-3.68	21.41	25.09	Average

[Test Mode #2]

< 1 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
134.20	54.62	20.18	5.9	-80	0.70	45.05	44.35	Peak
134.20	54.22	20.18	5.9	-80	0.30	25.05	24.75	Average

50 % Battery Status

	Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
	161.20	43.82	20.18	5.9	-80	-10.10	43.46	53.56	Peak
L	161.20	43.61	20.18	5.9	-80	-10.31	23.46	33.77	Average

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Spurious Test Data: FET #1 (CSD17308Q3, Texas Instruments)

[Test Mode #1]

Operating Frequency: 110 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
370.00	34.61	20.18	5.9	-80	-19.31	36.24	55.55	Peak
370.00	34.55	20.18	5.9	-80	-19.37	16.24	35.61	Average

Operating Frequency: 157.5 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
380.80	30.36	20.18	5.9	-80	-23.56	35.99	59.55	Peak
380.80	30.11	20.18	5.9	-80	-23.81	15.99	39.80	Average

Operating Frequency: 205 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
467.20	27.72	20.18	5.9	-80	-26.20	34.21	60.41	Peak
467.20	27.51	20.18	5.9	-80	-26.41	14.21	40.62	Average

[Test Mode #2]

< 1 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
407.80	30.77	20.18	5.9	-80	-23.15	35.40	58.55	Peak
407.80	30.42	20.18	5.9	-80	-23.50	15.40	38.90	Average

50 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
483.40	21.69	20.18	5.9	-80	-32.23	33.92	66.15	Peak
483.40	21.32	20.18	5.9	-80	-32.60	13.92	46.52	Average

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Fundamental Test Data: FET #2 (AON7200, Alpha & Omega Semiconductor)

[Test Mode #1]

Operating Frequency: 110 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
115.4	64.4	20.18	5.9	-80	10.48	46.36	35.88	Peak
115.4	63.9	20.18	5.9	-80	9.98	26.36	16.38	Average

Operating Frequency: 157.5 kHz

Freq. (kHz)		ading BuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
156.2	5	5.3	20.18	5.9	-80	1.38	43.73	42.35	Peak
156.2	5	4.3	20.18	5.9	-80	0.38	23.73	23.35	Average

Operating Frequency: 205 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
203.4	51.4	20.18	5.9	-80	-2.52	41.44	43.96	Peak
204.4	50.9	20.18	5.9	-80	-3.02	21.44	24.46	Average

[Test Mode #2]

< 1 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
121.6	53.5	20.18	5.9	-80	-0.42	45.91	46.33	Peak
121.6	53.1	20.18	5.9	-80	-0.82	25.91	26.73	Average

50 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
159.3	44.6	20.18	5.9	-80	-9.32	43.56	52.88	Peak
159.3	43.5	20.18	5.9	-80	-10.42	23.56	33.98	Average

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Spurious Test Data: FET #2 (AON7200, Alpha & Omega Semiconductor)

[Test Mode #1]

Operating Frequency: 110 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
346.2	36.1	20.18	5.9	-80	-17.82	36.82	54.64	Peak
346.2	35.8	20.18	5.9	-80	-18.12	16.82	34.94	Average

Operating Frequency: 157.5 kHz

	Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
ſ	468.6	31.2	20.18	5.9	-80	-22.72	34.19	56.91	Peak
Γ	468.6	30.4	20.18	5.9	-80	-23.52	14.19	37.71	Average

Operating Frequency: 205 kHz

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
610.2	28.9	20.18	5.9	-80	-25.02	31.89	56.91	Peak
610.2	28.1	20.18	5.9	-80	-25.82	11.89	37.71	Average

[Test Mode #2]

< 1 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
364.8	30.4	20.18	5.9	-80	-23.52	36.36	59.88	Peak
364.8	30.2	20.18	5.9	-80	-23.72	16.36	40.08	Average

50 % Battery Status

Freq. (kHz)	Reading (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Distance Correction	Result (dBuV/m)	Limit (dBuV/m)	Margin (dBuV/m)	Detect Mode
477.9	23.1	20.18	5.9	-80	-30.82	34.02	64.84	Peak
477.9	22.9	20.18	5.9	-80	-31.02	14.02	45.04	Average

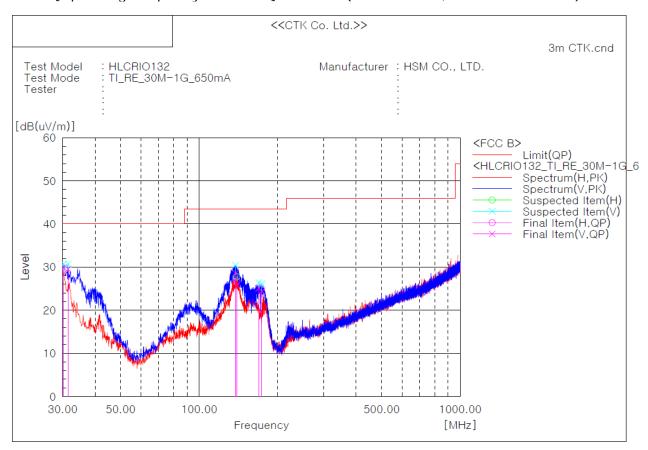
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[Operating Frequency: 110 kHz]: FET #1 (CSD17308Q3, Texas Instruments)



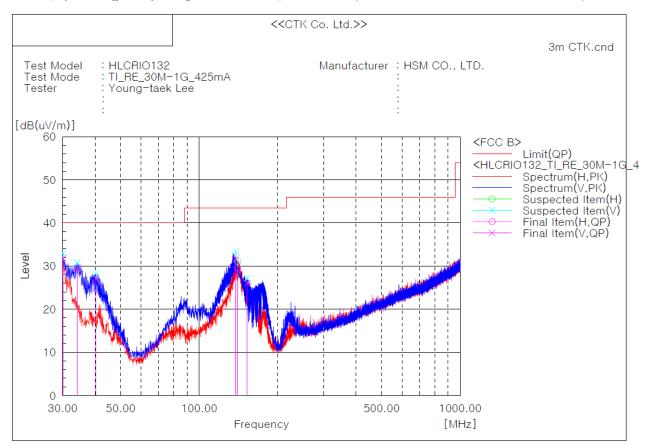
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.243	V	36.5	-6.6	29.9	40.0	10.1	100.0	160.0
2	31.455	V	36.6	- 7.1	29.5	40.0	10.5	100.0	197.0
3	137.913	V	40.8	-12.2	28.6	43.5	14.9	100.0	309.0
4	139.610	Н	38.9	-12.2	26.7	43.5	16.8	207.0	48.0
5	169.438	V	38.9	-13.8	25.1	43.5	18.4	100.0	271.0
6	173.924	V	38.5	-14.1	24.4	43.5	19.1	100.0	309.0

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[Operating Frequency: 157.5 kHz]: FET #1 (CSD17308Q3, Texas Instruments)



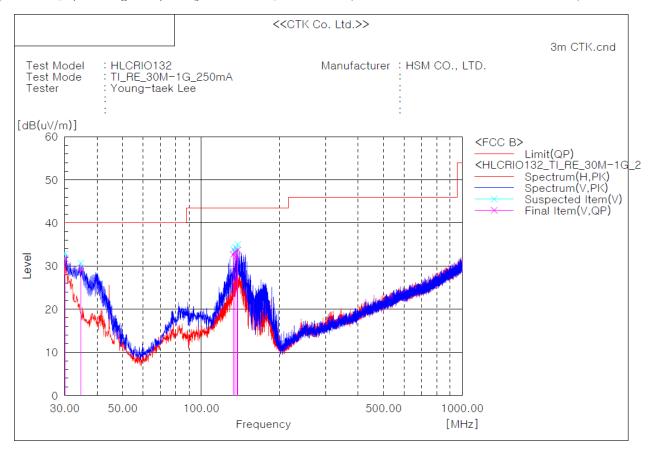
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result OP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.121	V	38.4	-6.6	31.8	40.0	8.2	100.0	48.0
2	34.123	V	37.8	-8.3	29.5	40.0	10.5	100.0	160.0
3	40.185	V	38.3	-11.2	27.1	40.0	12.9	100.0	271.0
4	138.276	V	43.9	-12.2	31.7	43.5	11.8	100.0	85.0
5	140.459	Η	41.8	-12.2	29.6	43.5	13.9	207.0	48.0
6	152.948	V	38.5	-12.5	26.0	43.5	17.5	100.0	308.0

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[Operating Frequency: 205 kHz]: FET #1 (CSD17308Q3, Texas Instruments)



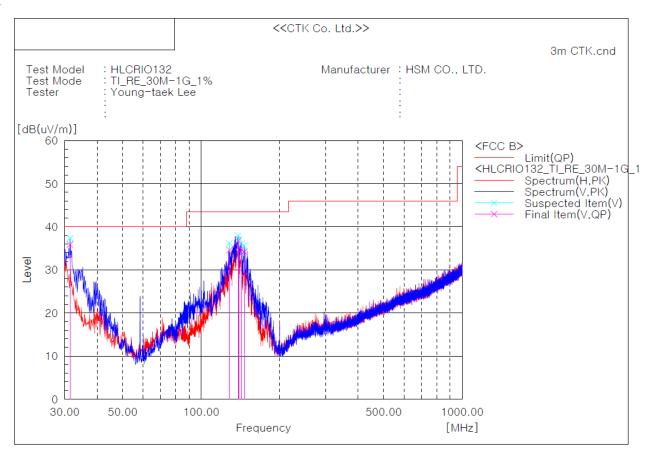
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.121	V	38.3	-6.6	31.7	40.0	8.3	100.0	309.0
2	34.608	V	38.0	-8.5	29.5	40.0	10.5	100.0	309.0
3	132.820	V	44.9	-12.2	32.7	43.5	10.8	100.0	234.0
4	134.881	V	45.5	-12.2	33.3	43.5	10.2	100.0	309.0
5	137.306	V	44.6	-12.2	32.4	43.5	11.1	100.0	197.0
6	138.155	V	45.9	-12.2	33.7	43.5	9.8	100.0	309.0

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[< 1 % Battery Status] : FET #1 (CSD17308Q3, Texas Instruments)



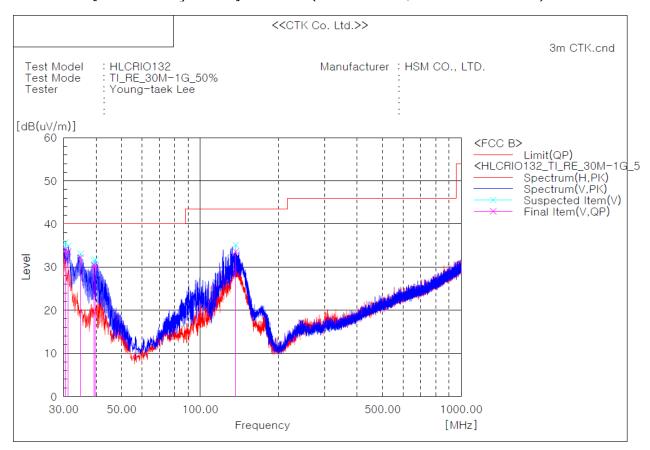
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	31.455	V	43.0	- 7.1	35.9	40.0	4.1	100.0	309.0
2	138.640	V	48.9	-12.2	36.7	43.5	6.8	100.0	309.0
3	139.489	V	47.6	-12.2	35.4	43.5	8.1	100.0	309.0
4	128.213	V	46.7	-12.1	34.6	43.5	8.9	100.0	11.0
5	142.763	V	47.0	-12.3	34.7	43.5	8.8	100.0	271.0
6	146.400	V	46.5	-12.3	34.2	43.5	9.3	100.0	234.0

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[50 % Battery Status]: FET #1 (CSD17308Q3, Texas Instruments)



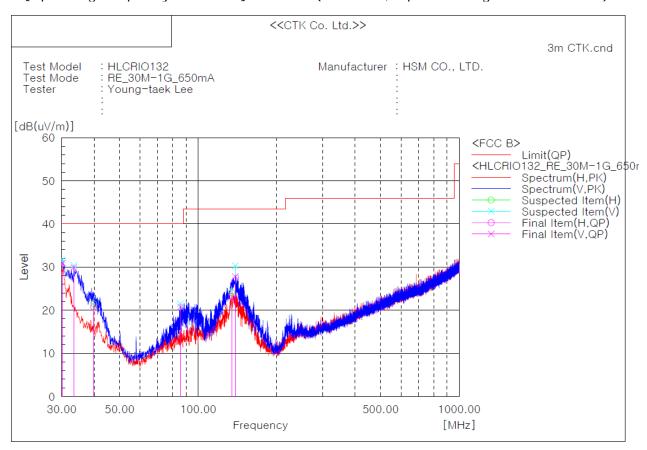
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.485	V	40.8	-6.7	34.1	40.0	5.9	100.0	48.0
2	31.213	V	40.6	- 7.0	33.6	40.0	6.4	100.0	86.0
3	34.850	V	40.8	-8.6	32.2	40.0	7.8	100.0	0.0
4	39.215	V	41.2	-10.7	30.5	40.0	9.5	100.0	272.0
5	39.700	V	41.1	-11.0	30.1	40.0	9.9	100.0	309.0
6	136.943	V	45.8	-12.2	33.6	43.5	9.9	100.0	272.0

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[Operating Frequency: 110 kHz]: FET #2 (AON7200, Alpha & Omega Semiconductor)



Final Result

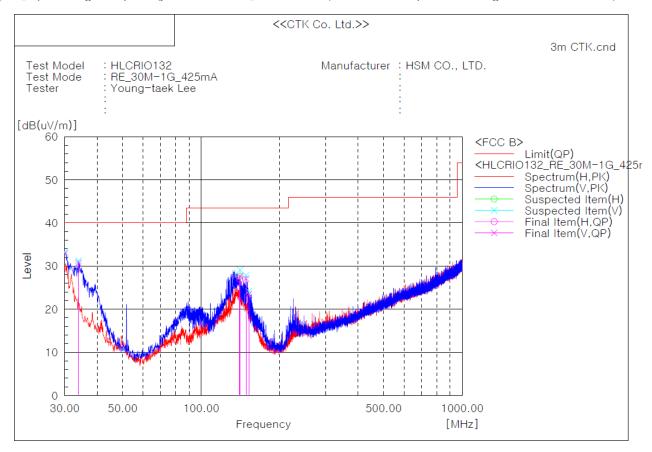
No.	Frequency	(P)	Reading QP	c.f	Result OP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.243	V	37.6	-6.6	31.0	40.0	9.0	100.0	11.0
2	33.395	V	37.9	-8.0	29.9	40.0	10.1	100.0	235.0
3	39.821	Н	31.9	-11.1	20.8	40.0	19.2	207.0	197.0
4	85.533	V	36.7	-15.9	20.8	40.0	19.2	100.0	272.0
5	134.518	Η	35.4	-12.2	23.2	43.5	20.3	207.0	48.0
6	138.883	V	40.0	-12.2	27.8	43.5	15.7	100.0	272.0

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[Operating Frequency: 157.5 kHz]: FET #2 (AON7200, Alpha & Omega Semiconductor)



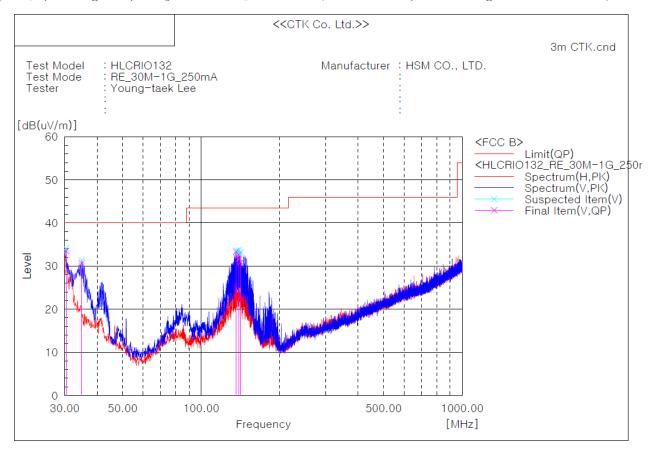
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.000	V	39.4	-6.5	32.9	40.0	7.1	100.0	85.0
2	33.880	V	38.9	-8.2	30.7	40.0	9.3	100.0	11.0
3	140.580	Н	39.2	-12.2	27.0	43.5	16.5	208.0	48.0
4	140.944	V	39.8	-12.2	27.6	43.5	15.9	100.0	309.0
5	148.583	V	39.5	-12.4	27.1	43.5	16.4	100.0	309.0
6	152.220	V	36.0	-12.5	23.5	43.5	20.0	100.0	271.0

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[Operating Frequency: 205 kHz]: FET #2 (AON7200, Alpha & Omega Semiconductor)



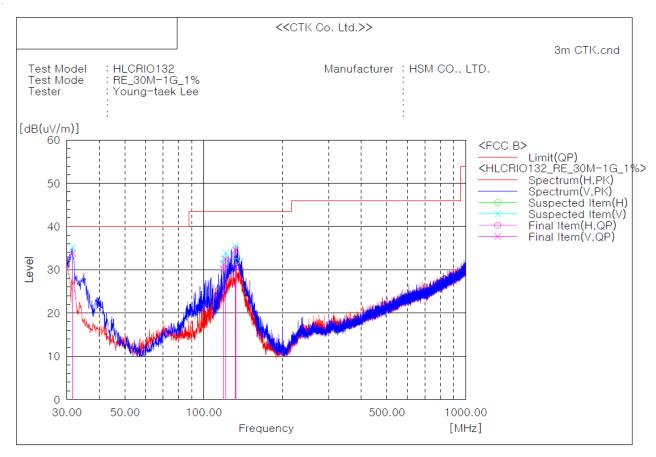
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result OP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.364	V	40.2	-6.7	33.5	40.0	6.5	100.0	123.0
2	34.850	V	39.3	-8.6	30.7	40.0	9.3	100.0	10.0
3	136.336	V	45.5	-12.2	33.3	43.5	10.2	100.0	48.0
4	139.246	V	44.8	-12.2	32.6	43.5	10.9	100.0	48.0
5	139.731	V	43.9	-12.2	31.7	43.5	11.8	100.0	272.0
6	141.793	V	43.1	-12.2	30.9	43.5	12.6	100.0	234.0

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[< 1 % Battery Status]: FET #2 (AON7200, Alpha & Omega Semiconductor)



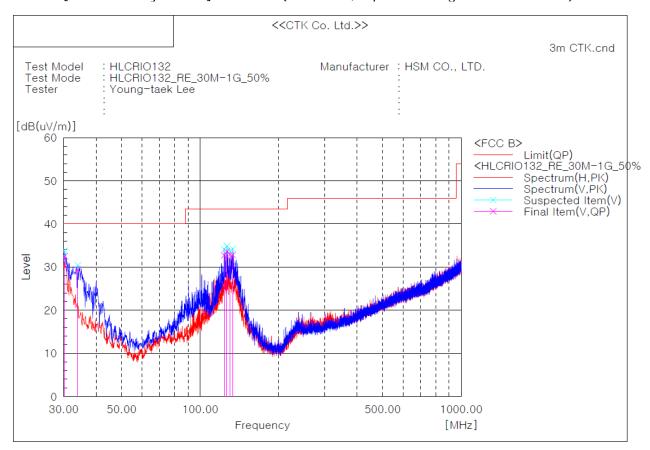
Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	31.576	V	41.0	-7.2	33.8	40.0	6.2	100.0	309.0
2	118.876	V	42.4	-12.2	30.2	43.5	13.3	100.0	309.0
3	119.240	V	43.4	-12.2	31.2	43.5	12.3	100.0	309.0
4	121.180	V	44.7	-12.2	32.5	43.5	11.0	100.0	309.0
5	132.335	V	46.8	-12.2	34.6	43.5	8.9	100.0	197.0
6	132.941	Н	43.2	-12.2	31.0	43.5	12.5	207.0	86.0

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[50 % Battery Status]: FET #2 (AON7200, Alpha & Omega Semiconductor)



Final Result

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	30.243	V	39.1	-6.6	32.5	40.0	7.5	100.0	11.0
2	34.001	V	37.6	-8.2	29.4	40.0	10.6	100.0	234.0
3	123.605	V	44.8	-12.1	32.7	43.5	10.8	100.0	309.0
4	126.636	V	45.7	-12.1	33.6	43.5	9.9	100.0	309.0
5	130.274	V	45.2	-12.2	33.0	43.5	10.5	100.0	309.0
6	133.305	V	45.0	-12.2	32.8	43.5	10.7	100.0	309.0

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APPENDIX A – Test Equipment Used For Tests

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date
1	EMI Test Receiver	Rohde & Schwarz	ESC17	100814	2015-12-05
2	Active Loop Antenna	SCHWARZBECK	FMZB 1513	1513-125	2015-06-13
3	Bilog Antenna	Schaffner	CBL6111C	2551	2015-05-08
4	6dB Attenuator	Rohde & Schwarz	DNF	272.4110.50	2015-11-20
5	AMPLIFIER	Sonoma Instrument Co.	310	291721	2016-02-02
6	Radio Communication Tester	Rohde & Schwarz	CMU200	106765	2016-02-06

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